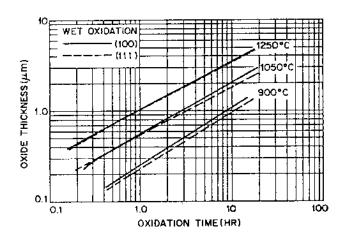
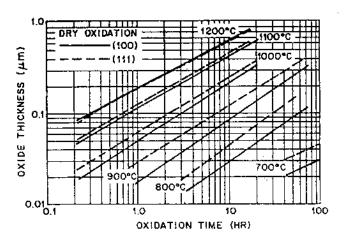
1. How long will it take to thermally grow a 1.5  $\mu$ m thick SiO<sub>2</sub> film on a (100) substrate at 1000 °C, by (a) wet oxidation, and (b) 0.2  $\mu$ m dry and then 1.5  $\mu$ m wet oxidation

How about growing a 2.5  $\mu m$  thick wet  $SiO_2$  at 1050  $^{\circ}C$ 





2. Can you estimate the residual stress of the  $SiO_2$  film for problem 1, (a) after the substrate is brought outside the furnace (T = 30 °C)

Thermal expansion coefficients : Si : 2.3 x  $10^{-6}$ /  $^{\circ}C$  , and  $SiO_2$ : 5 x  $10^{-7}$ /  $^{\circ}C$ 

Young's modulus :  ${\bf SiO_2}$  : 60 GPa

3. If the SiO<sub>2</sub> film in Prob. 2 is only grown on one side of the substrate, then the substrate will be deformed like I or II, why?

